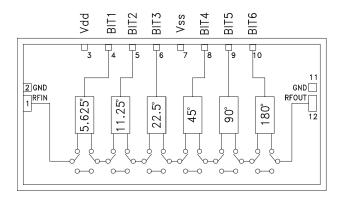


Typical Applications

The HMC647 is ideal for:

- EW Receivers
- · Weather & Military Radar
- Satellite Communications
- Beamforming Modules
- Phase Cancellation

Functional Diagram



Features

Low RMS Phase Error: 1.0° Low Insertion Loss: 4 dB High Linearity: +54 dBm Positive Control Logic 360° Coverage, LSB = 5.625°

Die Size: 3.85 x 1.85 x 0.1 mm

General Description

The HMC647 is a 6-bit digital phase shifter die which is rated from 2.5 to 3.1 GHz, providing 360 degrees of phase coverage, with a LSB of 5.625 degrees. The HMC647 features very low RMS phase error of 1.0 degrees and extremely low insertion loss variation of ± 0.5 dB across all phase states. This high accuracy phase shifter is controlled with positive control logic of 0/ \pm 5V, and is internally matched to 50 Ohms with no external components.

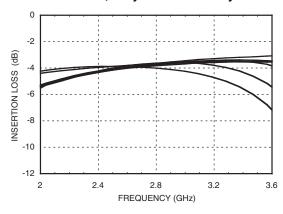
Electrical Specifications, $T_A = +25^{\circ}$ C, Vss= -5V, Vdd= +5V, Control Voltage = 0/+5V, 50 Ohm System

| Parameter | Min. | Тур. | Max. | Units |
|----------------------------------|------|------|----------|-------|
| Frequency Range | 2.5 | | 3.1 | GHz |
| Insertion Loss* | | 4 | 6 | dB |
| Input Return Loss* | | 16 | | dB |
| Output Return Loss* | | 17 | | dB |
| Phase Error* | | ±3 | +5 / -15 | deg |
| RMS Phase Error | | 1.0 | | deg |
| Insertion Loss Variation* | | ±0.5 | | dB |
| Input Power for 1 dB Compression | | 31 | | dBm |
| Input Third Order Intercept | | 54 | | dBm |
| Control Voltage Current | | <250 | | μΑ |
| Bias Control Current | | <12 | | mA |

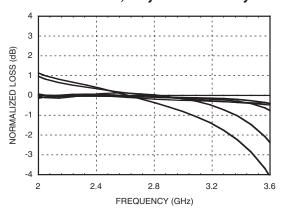
^{*}Note: Major States Shown



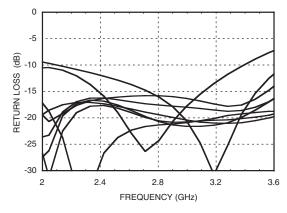
Insertion Loss, Major States Only



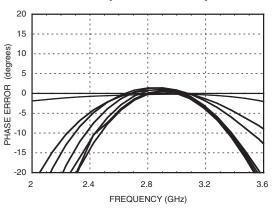
Normalized Loss, Major States Only



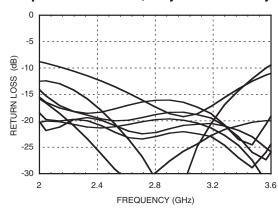
Input Return Loss, Major States Only



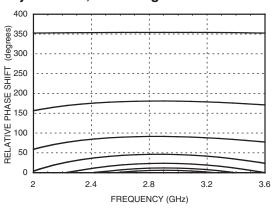
Phase Error, Major States Only



Output Return Loss, Major States Only

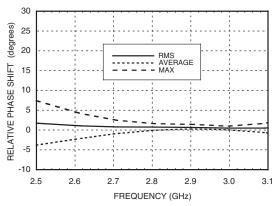


Relative Phase Shift Major States, Including All Bits

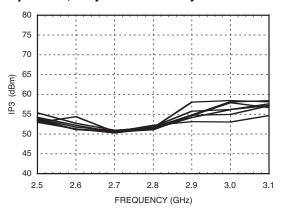




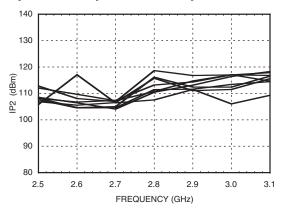
Relative Phase Shift, RMS, Average, Max, All States



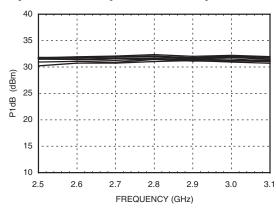
Input IP3, Major States Only



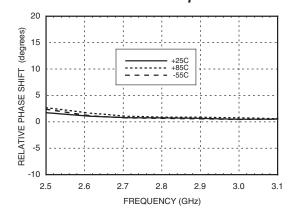
Input IP2, Major States Only



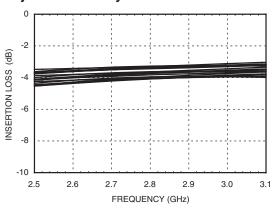
Input P1dB, Major States Only



RMS Phase Error vs. Temperature

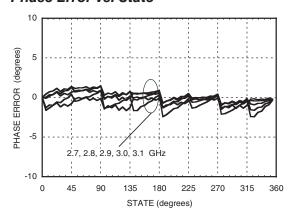


Insertion Loss vs. Temperature, Major States Only





Phase Error vs. State



Absolute Maximum Ratings

| Input Power (RFIN) | 26 dBm (T= +85 °C) |
|--------------------------------------------|--------------------|
| Bias Voltage Range (Vdd) | -0.2 to +12V |
| Bias Voltage Range (Vss) | +0.2 to -12V |
| Channel Temperature (Tc) | 150 °C |
| Thermal Resistance (channel to die bottom) | 140 °C/W |
| Storage Temperature | -65 to +150 °C |
| Operating Temperature | -55 to +85 °C |



Bias Voltage & Current

| Vdd | Idd |
|------|-------|
| 5.0 | 5.3mA |
| Vss | Iss |
| -5.0 | 5.3mA |

Control Voltage

| State | Bias Condition | |
|----------|---------------------------|--|
| Low (0) | 0 to 0.2 Vdc | |
| High (1) | Vdd ±0.2 Vdc @ 35 μA Typ. | |

Truth Table

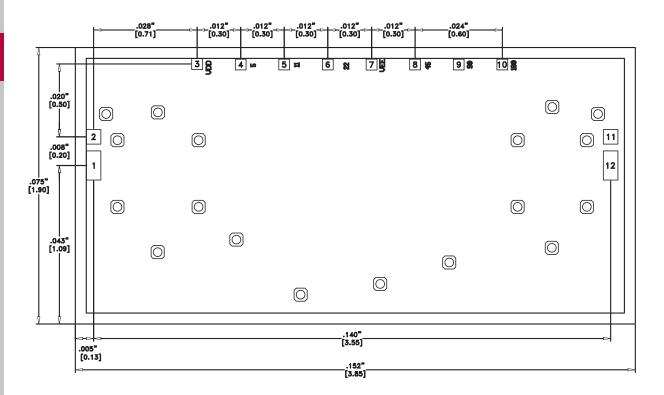
| Control Voltage Input | | | | | Phase Shift | | |
|-----------------------|-------|-------|-------|-------|-------------|---------------------------|--|
| Bit 1 | Bit 2 | Bit 3 | Bit 4 | Bit 5 | Bit 6 | (Degrees) RFIN - RFOUT | |
| 0 | 0 | 0 | 0 | 0 | 0 | Reference* | |
| 1 | 0 | 0 | 0 | 0 | 0 | 5.625 | |
| 0 | 1 | 0 | 0 | 0 | 0 | 11.25 | |
| 0 | 0 | 1 | 0 | 0 | 0 | 22.5 | |
| 0 | 0 | 0 | 1 | 0 | 0 | 45.0 | |
| 0 | 0 | 0 | 0 | 1 | 0 | 90.0 | |
| 0 | 0 | 0 | 0 | 0 | 1 | 180.0 | |
| 1 | 1 | 1 | 1 | 1 | 1 | 354.375 | |

Any combination of the above states will provide a phase shift approximately equal to the sum of the bits selected.

*Reference corresponds to monotonic setting



Outline Drawing



Die Packaging Information [1]

| Standard | Alternate |
|----------|-----------|
| GP-1 | [2] |

[1] Refer to the "Packaging Information" section for die packaging dimensions.

NOTES:

- 1. ALL DIMENSIONS IN INCHES (MILLIMETERS)
- 2. DIE THICKNESS IS 0.004
- 3. BACKSIDE METALLIZATION: GOLD
- 4. BACKSIDE METAL IS GROUND
- 5. BOND PADS METALLIZATION: GOLD
- 6. OVERALL DIE SIZE ±0.002

^[2] For alternate packaging information contact Hittite Microwave Corporation.

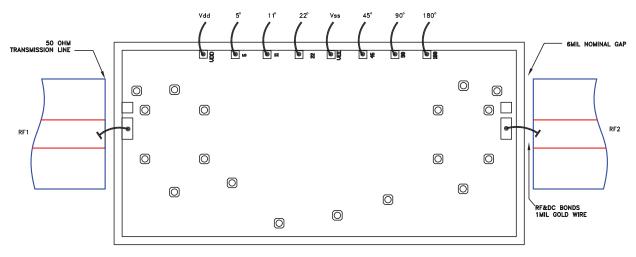


Pad Descriptions

| Pad Number | Function | Description | Interface Schematic |
|------------------|---------------------------------------|--------------------------------------------------------------|---------------------|
| 1 | RFIN | This port is DC coupled and matched to 50 Ohms. | RFIN O- |
| 2, 11 | GND | These pads and die bottom must be connected to RF/DC ground. | = O GND |
| 3 | Vdd | Supply voltage. | |
| 4 - 6, 8 - 10 | BIT1, BIT2, BIT3, BIT4, BIT5. BIT6 | Control Input. See truth table and control voltage tables. | - |
| 7 | Vss | Supply voltage. | |
| 12 | RFOUT | This port is DC coupled and matched to 50 Ohms. | |



Assembly Diagram



Handling Precautions

Follow these precautions to avoid permanent damage.

Storage: All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against > ± 250V ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.

General Handling: Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip has fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

Mounting

The chip is back-metallized and can be die mounted with electrically conductive epoxy. The mounting surface should be clean and flat.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

Ball or wedge bond with 0.025mm (1 mil) diameter pure gold wire. Thermosonic wirebonding with a nominal stage temperature of 150 deg. C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Use the minimum level of ultrasonic energy to achieve reliable wirebonds. Wirebonds should be started on the chip and terminated on the package or substrate. All bonds should be as short as possible <0.31mm (12 mils).



Notes